

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/051,073	MURAKAMI, TAKASHI	
		Examiner	Art Unit	Page 1 of 1
		Yuwen Pan	2682	

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English translation of JP 409046110
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